

DATA SHEET

For a complete data sheet, please also download:

- The IC04 LOCMOS HE4000B Logic Family Specifications HEF, HEC
- The IC04 LOCMOS HE4000B Logic Package Outlines/Information HEF, HEC

HEF4557B

LSI

1-to-64 bit variable length shift register

Product specification
File under Integrated Circuits, IC04

January 1995

1-to-64 bit variable length shift register

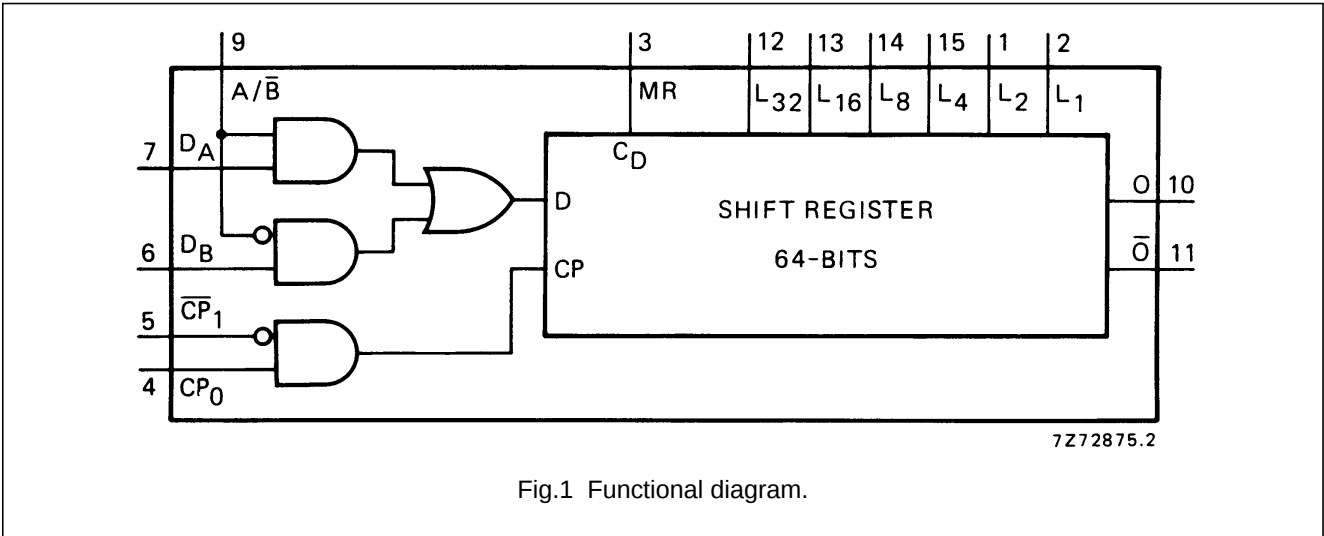
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DESCRIPTION

The HEF4557B is a static clocked serial shift register whose length may be programmed to be any number of bits between 1 and 64. The number of bits selected is equal to the sum of the subscripts of the enabled length control inputs (L_1 , L_2 , L_4 , L_8 , L_{16} and L_{32}) plus one. Serial data may be selected from the D_A or D_B data inputs with the $A/\overline{B}$ select input. This feature is useful for recirculation

purposes. Information on D_A or D_B is shifted into the first register position and all the data in the register is shifted one position to the right on the LOW to HIGH transition of CP_0 while $\overline{CP_1}$ is LOW or on the HIGH to LOW transition of $\overline{CP_1}$ while CP_0 is HIGH. A HIGH on master reset (MR) resets the register and forces O to LOW and $\overline{O}$ to HIGH, independent of the other inputs.



PINNING

- D_A , D_B

data inputs
- $A/\overline{B}$

select data input
- CP_0

clock input
- $\overline{CP_1}$

clock enable input
- MR

asynchronous master reset
- L_1 to L_{32}

bit-length control inputs
- O , $\overline{O}$

buffered outputs

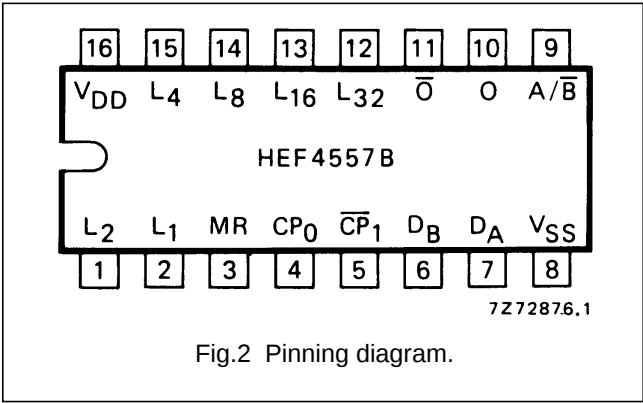
- HEF4557BP(N):

16-lead DIL; plastic (SOT38-1)
- HEF4557BD(F):

16-lead DIL; ceramic (cerdip) (SOT74)
- HEF4557BT(D):

16-lead SO; plastic (SOT109-1)
- ():

Package Designator North America



FAMILY DATA, I_{DD} LIMITS category LSI

See Family Specifications

1-to-64 bit variable length shift register

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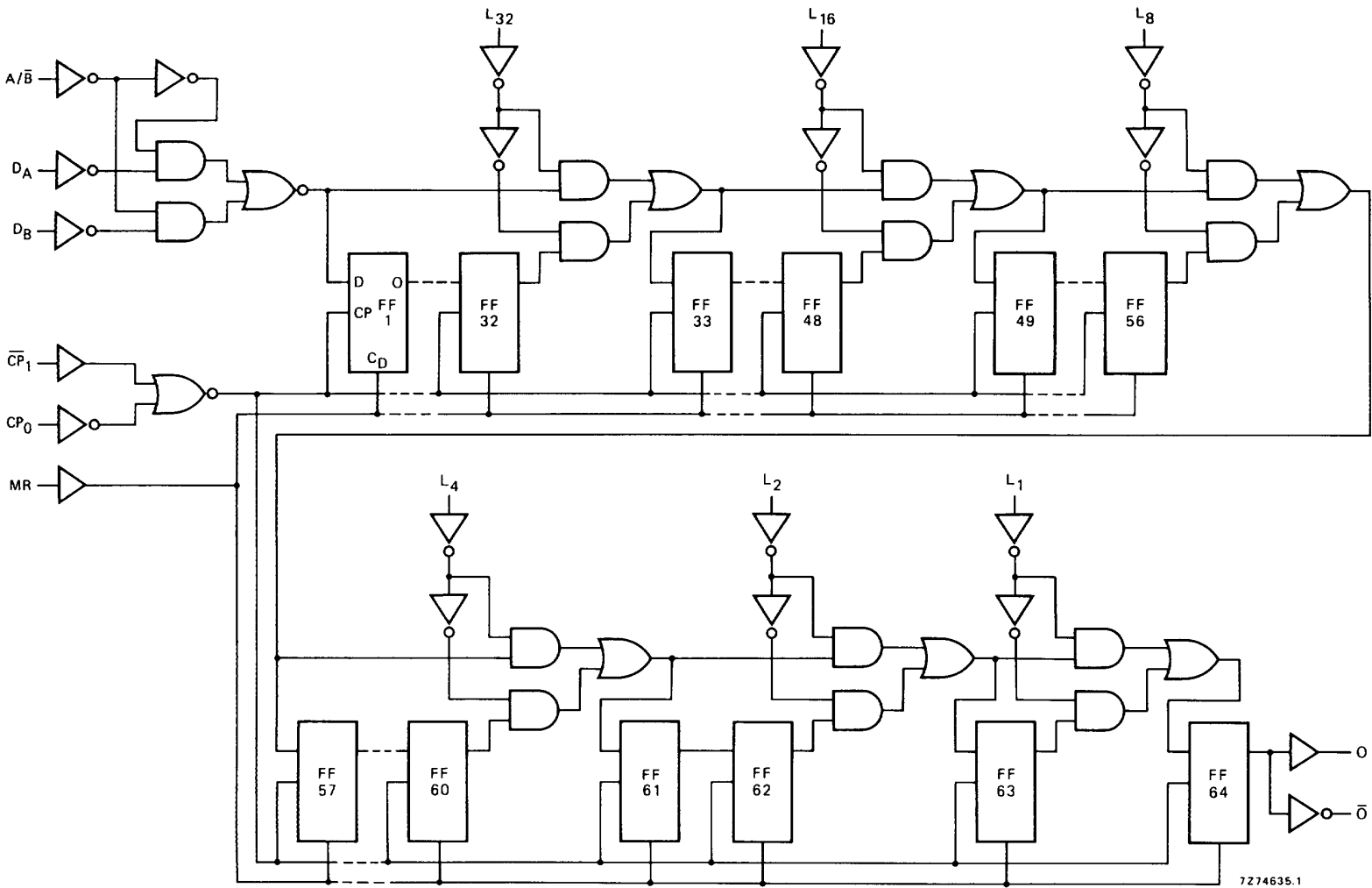


Fig.3 Logic diagram.

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FUNCTION TABLE

INPUTS						OUTPUT
MR	A/B	D _A	D _B	CP _O	CP ₁	O ⁽¹⁾
L	L	D ₁	D ₂	$\nearrow$	L	D ₂
L	H	D ₁	D ₂	$\nearrow$	L	D ₁
L	L	D ₁	D ₂	H	$\searrow$	D ₂
L	H	D ₁	D ₂	H	$\searrow$	D ₁
H	X	X	X	X	X	L

Notes

1. The moment D_n appears at O depends on the bit-length shown in the table below.
2. H = HIGH state (the more positive voltage)
3. L = LOW state (the less positive voltage)
4. X = state is immaterial
5. $\nearrow$ = positive-going transition
6. $\searrow$ = negative-going transition
7. D_n = either HIGH or LOW

BIT-LENGTH SELECT FUNCTION TABLE

L ₃₂	L ₁₆	L ₈	L ₄	L ₂	L ₁	REGISTER LENGTH
L	L	L	L	L	L	1-bit
L	L	L	L	L	H	2-bits
L	L	L	L	H	L	3-bits
L	L	L	L	H	H	4-bits
L	L	L	H	L	L	5-bits
L	L	L	H	L	H	6-bits
L	L	L	H	H	L	7-bits
L	L	L	H	H	H	8-bits
↓	↓	↓	↓	↓	↓	↓
L	H	H	H	H	H	32-bits
H	L	L	L	L	L	33-bits
H	L	L	L	L	H	34-bits
↓	↓	↓	↓	↓	↓	↓
H	H	H	H	L	L	61-bits
H	H	H	H	L	H	62-bits
H	H	H	H	H	L	63-bits
H	H	H	H	H	H	64-bits

AC CHARACTERISTICS

V_{SS} = 0 V; T_{amb} = 25 °C; input transition times ≤ 20 ns

	V _{DD} V	TYPICAL FORMULA FOR P (μW)	
Dynamic power dissipation per package (P)	5 10 15	3 500 f _i + ∑ (f _o C _L) × V _{DD} ² 15 000 f _i + ∑ (f _o C _L) × V _{DD} ² 37 000 f _i + ∑ (f _o C _L) × V _{DD} ²	where f _i = input freq. (MHz) f _o = output freq. (MHz) C _L = load capacitance (pF) ∑ (f _o C _L) = sum of outputs V _{DD} = supply voltage (V)

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AC CHARACTERISTICS

 $V_{SS} = 0$ V; $T_{amb} = 25$ °C; $C_L = 50$ pF; input transition times ≤ 20 ns

	V_{DD} V	SYMBOL	TYP.	MAX.		TYPICAL EXTRAPOLATION FORMULA
Propagation delays $CP_0, \overline{CP}_1 \rightarrow O, \overline{O}$ HIGH to LOW	5	t_{PHL}	240	480	ns	213 ns + (0,55 ns/pF) C_L
	10		90	180	ns	79 ns + (0,23 ns/pF) C_L
	15		65	130	ns	57 ns + (0,16 ns/pF) C_L
	5	t_{PLH}	240	480	ns	213 ns + (0,55 ns/pF) C_L
	10		90	180	ns	79 ns + (0,23 ns/pF) C_L
	15		65	130	ns	57 ns + (0,16 ns/pF) C_L
	5	t_{PHL}	170	340	ns	143 ns + (0,55 ns/pF) C_L
	10		80	160	ns	69 ns + (0,23 ns/pF) C_L
	15		60	120	ns	52 ns + (0,16 ns/pF) C_L
	5	t_{PLH}	140	280	ns	113 ns + (0,55 ns/pF) C_L
	10		70	140	ns	59 ns + (0,23 ns/pF) C_L
	15		55	110	ns	47 ns + (0,16 ns/pF) C_L
Output transition times HIGH to LOW	5	t_{THL}	60	120	ns	10 ns + (1,0 ns/pF) C_L
	10		30	60	ns	9 ns + (0,42 ns/pF) C_L
	15		20	40	ns	6 ns + (0,28 ns/pF) C_L
	5	t_{TLH}	60	120	ns	10 ns + (1,0 ns/pF) C_L
	10		30	60	ns	9 ns + (0,42 ns/pF) C_L
	15		20	40	ns	6 ns + (0,28 ns/pF) C_L

Interpolation table (see note next page)

LENGTH CONTROL INPUTS						MINIMUM NUMBER OF BITS SELECTED	SET-UP, HOLD, RECOVERY TIMES
L_1	L_2	L_4	L_8	L_{16}	L_{32}		
L	L	L	L	L	L	1	specified
H	L	L	L	L	L	2	
X	H	L	L	L	L	3	
X	X	H	L	L	L	5	
X	X	X	H	L	L	9	
X	X	X	X	H	L	17	
X	X	X	X	X	H	33	specified

Notes

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AC CHARACTERISTICS

 $V_{SS} = 0$ V; $T_{amb} = 25$ °C; $C_L = 50$ pF; input transition times ≤ 20 ns; see also waveforms Fig.4

	V_{DD} V	SYMBOL	MIN.	TYP.	
Minimum clock pulse width; LOW for CP_0 or HIGH for $\overline{CP}_1$	5 10 15	t_{WCPL} or t_{WCPH}	180 60 40	90 30 20 ns	
Minimum reset pulse width; HIGH	5 10 15	t_{WMRH}	150 70 50	75 35 25 ns	
Set-up times $D_A, D_B, A/\overline{B} \rightarrow CP_0,$ $\overline{CP}_1$ L_1 to $L_{32} = \text{LOW}$	5 10 15	t_{su}	360 140 90	180 70 45 ns	see note
$L_{32} = \text{HIGH}$	5 10 15	t_{su}	40 35 30	-20 -10 -5 ns	
Hold times $D_A, D_B, A/\overline{B} \rightarrow CP_0,$ $\overline{CP}_1$ L_1 to $L_{32} = \text{LOW}$	5 10 15	t_{hold}	-40 -10 0	-110 -45 -30 ns	
$L_{32} = \text{HIGH}$	5 10 15	t_{hold}	90 60 50	30 20 15 ns	
Recovery times for MR L_1 to $L_{32} = \text{LOW}$	5 10 15	t_{RMR}	500 250 150	250 125 75 ns	
$L_{32} = \text{HIGH}$	5 10 15	t_{RMR}	110 70 60	50 30 25 ns	
Minimum clock pulse frequency	5 10 15	f_{max}	2,5 7 10	5 14 20 MHz	

Note

1. The set-up, hold and recovery times vary with the minimum number of bits selected. For other values as specified one may interpolate as shown in the table (see previous page).

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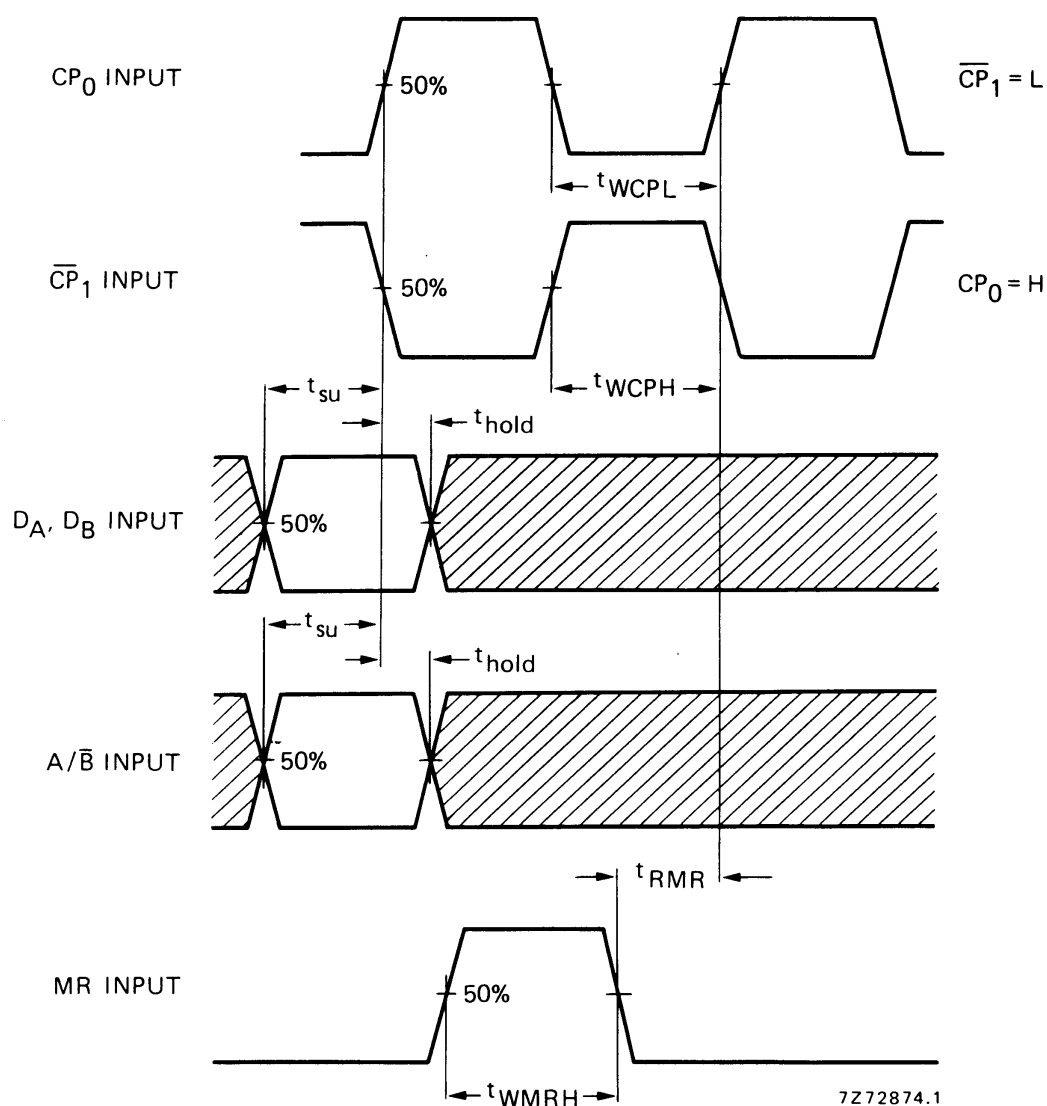
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Fig.4 Waveforms showing recovery time for MR and minimum CP_0 , $\overline{CP}_1$ and MR pulse widths, set-up and hold times for D_A , D_B and $A/\overline{B}$ to CP_0 and $\overline{CP}_1$. Set-up and hold times are shown as positive values but may be specified as negative values.